



<i>Interference Searched</i> 	Application/Control No. 10635314	Applicant(s)/Patent Under Reexamination ONITSUKA ET AL.
	Examiner Chang, Rick K	Art Unit 3729

Class	SubClass	Date	Examiner
29,248,269	subs. under searched	6/5/06	RC

U.S. Patent and Trademark Office	Part of Paper No.:	20060605
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<p style="text-align: center;">Searched</p> 	<p>Application/Control No.</p> <p>10635314</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>ONITSUKA ET AL.</p>
	<p>Examiner</p> <p>Chang, Rick K</p>	<p>Art Unit</p> <p>3729</p>


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search updated

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Search Notes 	Application/Control No. 10635314	Applicant(s)/Patent Under Reexamination ONITSUKA ET AL.
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